

**Notice of References Cited**

Application/Control No.

10/689,690

Applicant(s)/Patent Under  
Reexamination  
UN ET AL.

Examiner

DEWANDA SAMUEL

Art Unit

2416

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0149746	08-2003	Baldwin et al.	709/219
*	B	US-6,118,785	09-2000	Araujo et al.	370/401
*	C	US-7,117,530	10-2006	Lin, Yeejang James	726/15
*	D	US-2003/0078996	04-2003	Baldwin, David A.	709/220
*	E	US-6,226,751	05-2001	Arrow et al.	726/15
*	F	US-6,295,293	09-2001	Tonnby et al.	370/389
*	G	US-5,930,258	07-1999	Dato Solis et al.	370/401
*	H	US-6,985,935	01-2006	Zhang et al.	709/219
*	I	US-6,426,950	07-2002	Mistry, Dhansukh Nathubhai	370/352
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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